

ELECTRONIC INFORMATION DISCLOSURE STATEMENT

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Title of Invention	MULTI-RUN SELECTIVE PATTERN AND ETCH WAFER PROCESS																																																				
<p>Application Number:</p> <p>Confirmation Number:</p> <p>First Named Applicant: Kenneth Bandy</p> <p>Attorney Docket Number: BUR920020075US1</p> <p>Search string: (6245581 or 6232134 or 5980766 or 5790254 or 5629772).pn.</p> <p>US Patent Documents</p> <p>Note: Applicant is not required to submit a paper copy of cited US Patent Documents</p> <table border="1"><thead><tr><th>Init</th><th>Cite.No.</th><th>Patent No.</th><th>Date</th><th>Patentee</th><th>Kind</th><th>Class</th><th>Subclass</th></tr></thead><tbody><tr><td>LV</td><td>1</td><td>6245581</td><td>2001-06-12</td><td>Bonser et al.</td><td></td><td>438</td><td>8</td></tr><tr><td>LV</td><td>2</td><td>6232134</td><td>2001-05-15</td><td>Farber et al.</td><td></td><td>438</td><td>9</td></tr><tr><td>LV</td><td>3</td><td>5980766</td><td>1999-11-09</td><td>Flamm et all.</td><td></td><td>216</td><td>59</td></tr><tr><td>LV</td><td>4</td><td>5790254</td><td>1998-08-04</td><td>Ausschnitt</td><td></td><td>356</td><td>372</td></tr><tr><td>LV</td><td>5</td><td>5629772</td><td>1997-05-13</td><td>Ausschnitt</td><td></td><td>256</td><td>372</td></tr></tbody></table> <p>Signature</p> <table border="1"><thead><tr><th>Examiner Name</th><th>Date</th></tr></thead><tbody><tr><td>LAN VINH</td><td>2/14/05</td></tr></tbody></table>		Init	Cite.No.	Patent No.	Date	Patentee	Kind	Class	Subclass	LV	1	6245581	2001-06-12	Bonser et al.		438	8	LV	2	6232134	2001-05-15	Farber et al.		438	9	LV	3	5980766	1999-11-09	Flamm et all.		216	59	LV	4	5790254	1998-08-04	Ausschnitt		356	372	LV	5	5629772	1997-05-13	Ausschnitt		256	372	Examiner Name	Date	LAN VINH	2/14/05
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